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PATENT & TRADEMARK OFFICE

| INFORMATION DISCLOSURE CITATION PTO-1449 | CUSTOMER NUMBER 26615 | ATTORNEY'S DKT NO. F0685 | APPLICATION NO. 09/767,884 |
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| | | APPLICANT(S) Robert Williams | |
| | | FILING DATE January 24, 2001 | GROUP 2185 21 43 |

## U.S. PATENT DOCUMENTS

| EXAMINER'S INITIALS | PATENT NO. | DATE | NAME | CLASS | SUBCLASS | FILING DATE |
|---|---|---|---|---|---|---|
| MK | 6,654,347 | 11/25/03 | Wiedeman et al. | 370 | 241 | |
| MK | 5,592,625 | 01/07/97 | Sandberg | 395 | 200.08 | |
| MK | 6,108,308 | 08/22/00 | Flavin et al. | 370 | 238 | |
| MK | 5,978,951 | 11/02/99 | Lawler et al. | 714 | 758 | |
| MK | 6,681,258 | 01/20/04 | Ratcliff et al. | 709 | 245 | |
| MK | 5,892,912 | 04/06/99 | Suzuki et al. | 395 | 200.48 | |
| MK | 5,247,620 | 09/21/93 | Fukuzawa et al. | 395 | 325 | |
| | | | | | | |

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Technology Center 2100

## FOREIGN PATENT DOCUMENTS

| EXAMINER'S INITIALS | PATENT NO. | DATE | COUNTRY | CLASS | SUBCLASS | Translation Yes | No |
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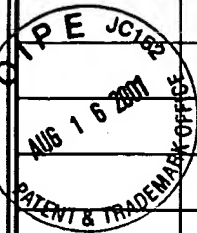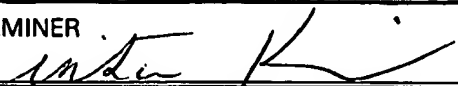
## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

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| INFORMATION DISCLOSURE CITATION PTO-1449 | 26615 PATENT TRADEMARK OFFICE | ATTORNEY'S DKT No. F0685 | APPLICATION No. 09/767,884 |
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| | | APPLICANT(S) WILLIAMS | |
| | | FILING DATE January 24, 2001 | GROUP ~~2485~~ 2143 |

## U.S. PATENT DOCUMENTS

| EXAMINER'S INITIALS | PATENT NO. | DATE | NAME | CLASS | SUBCLASS | FILING DATE |
|---|---|---|---|---|---|---|
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## FOREIGN PATENT DOCUMENTS

| EXAMINER'S INITIALS | PATENT NO. | DATE | COUNTRY | CLASS | SUBCLASS | Translation Yes | No |
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## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

| MK | U.S. Patent Application Serial No. 09/814,818, filed 03/23/2001. |
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| EXAMINER | DATE CONSIDERED 5/19/04 |
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